

Using SPENVIS to evaluate the Space Environment

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ECSS-E-ST-10-04C Trapped Rad. Belts Fluxes



Earth Orbit:

- 1. Long term average fluxes:
 - a. AE-8 and AP-8 models
 - b. IGE-2006 for GEO (+/- 500 km),"upper" model for "conservative" analyses
 - c. ONERA MEOv2 for electrons in GPS orbits (20000km circular +/- 500 km altitude), "upper" model for conservative analyses
- 2. Worst Case for Internal Charging:
 - a. FLUMIC v3 model
 - b. NASA worst case model for GEO
 - Can also be used for short term analyses (1 day → 1 month)
 of worst case cumulative radiation effects
- 3. Worst Case trapped proton fluxes:
 - a. No provision in the current standard

Solar Particles: ESP model, confidence level is a project decision.

Effects Requirements



- Dose (TID/TNID) ← total mission fluences
- 2. Solar cell degradation: ← total mission fluences
- 3. Internal charging ← peak daily fluences
- 4. Single event effects:
 - a. long term (destructive): ← total mission fluence, probabilities
 - b. Short term (SEU, Transients): ← peak fluxes, probabilities
- 5. Instrument background/noise:
 - a. Maximum noise levels: ← peak fluxes,
 - b. Loss of "science" ← duration of "events"
 - ← frequency of "events".
- 6. Material Degradation ← total mission fluences
 - ← low energies required (~ keV).

Confidence levels/Risk, uncertainty and errors → Margin policy

Outline



- 1. Introduction to SPENVIS getting started
- 2. Generate a mission trajectory
- 3. Overview of available radiation environment models
- 4. The various simple effects tools
 - a. SHIELDOSE
 - b. EQFLUX/MC-SCREAM
 - c. Single Event Effects
- 5. The Geant4 tools (Mulassis, SSAT, GRAS, GEMAT)
- 6. Advice, Exporting results & other useful features.

Registration



https://www.spenvis.oma.be/registration.php

Temporary Accounts available:

juice_1 juice_2

juice_70

Password for each is:

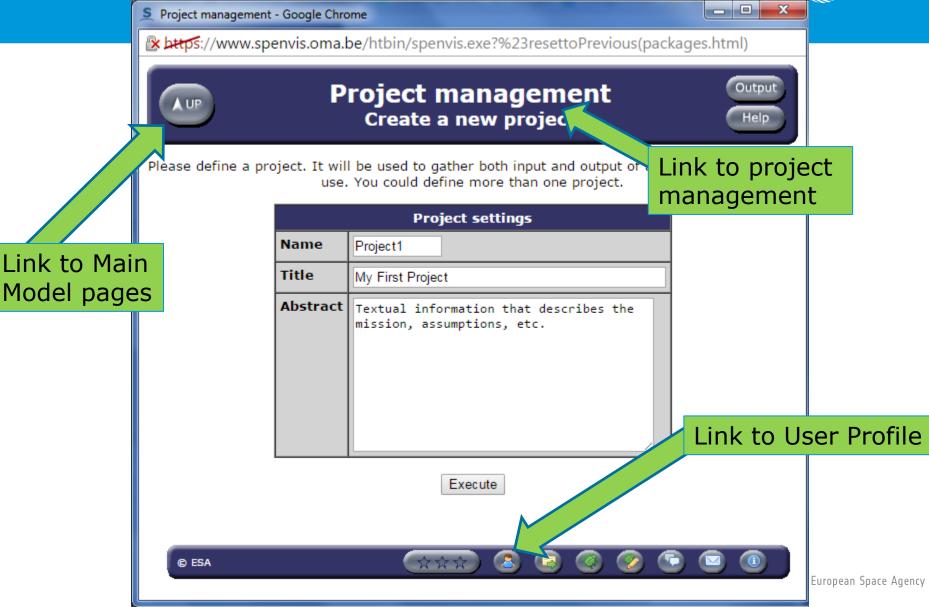
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Create a Project





A Mission Trajectory is required

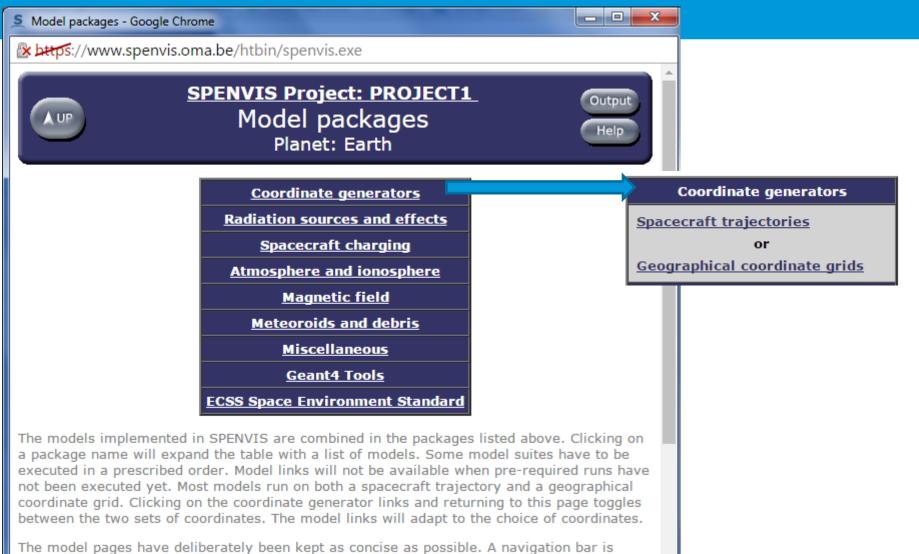


Three means of specifying the trajectory:

- Orbit Generator
- Upload trajectory file (SPENVIS format Advanced)
- Upload CCSDS OEM trajectory file (JOREM extension)
- Orbit generator uses ephemera and propagates the orbit
 - General
 - Semi-major axis/eccentricity
 - Apogee/perigee
 - Circular
 - Hyperbolic (for fly-by missions)
 - Geostationary
 - Helio-synchronous (SSO)
 - Near Earth Interplanetary

Model Home Page





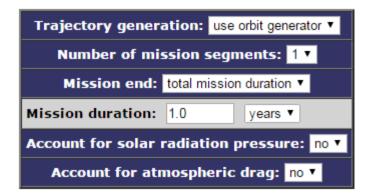
figured at the top of each SPENVIS page. The <u>Help</u> link in the bottom right hand corner of this bar points to context sensitive help pages, which in turn contain their own navigation system,

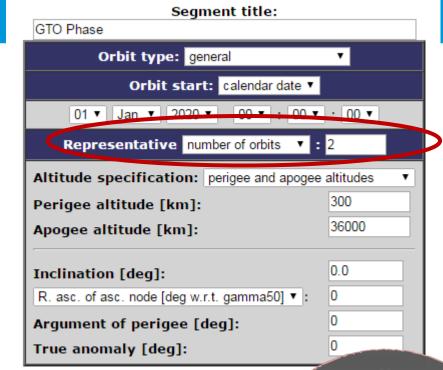
including access to guidelines on model usage and background information on the space

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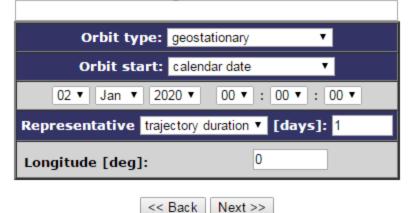
Traditional GEO

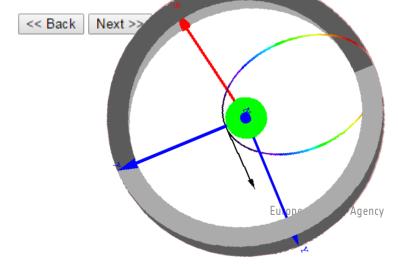






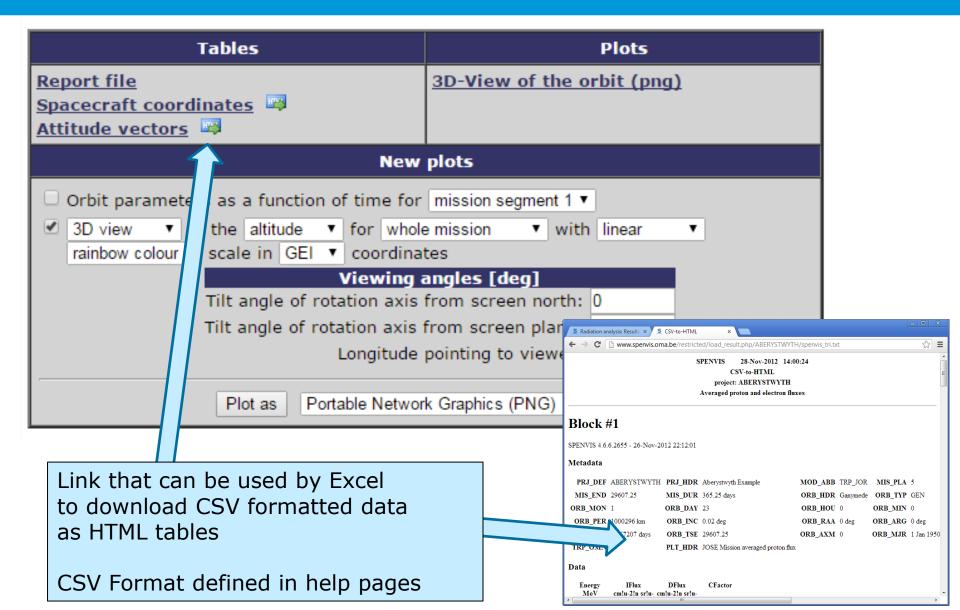
Segment title:





Output Pages





Radiation Models



Radiation sources include:

- Trapped radiation belts (AP8, AE8, IGE-2000, etc.)
- Solar protons (long, short term)
- Galactic cosmic rays

Models for all three sources in: "Radiation Sources and Effects"

In most cases, the default parameters should follow ECSS-E-ST-10-04C

Coordinate generators

Radiation sources and effects

Radiation sources

Trapped proton and electron fluxes

Trapped proton flux anisotropy

Short-term solar particle fluxes (only for SEU)

Long-term solar particle fluences

Galactic cosmic ray fluxes

Shielded flux

Solar cell radiation damage

Damage equivalent fluences for solar cells (EQFLUX)

NIEL based damage equivalent fluences for solar cells (MC-SCREAM)

Long-term radiation doses

Ionizing dose for simple geometries

Non-ionizing energy loss for simple geometries

Effective dose and ambient dose equivalent

Single event effects

Short-term SEU rates and LET spectra

Long-term SEU rates and LET spectra

Spacocraft charging

Radiation Belt Models



>> Go to the **IRENE AE9/AP9 model** (for evaluation)

Trapped radiation models Proton model: AP-8 Model version: solar minimum Threshold flux for exposure(/cm2/s): 1.00 Model developed by: Model developed by: Model developed by: Model developed by:

AP-8 and AE-8 come in two flavours: Solar minimum and Maximum Slight anomaly: the IGE-2006 model is only available if a single mission segment is selected and "Geostationary orbit" type selected.

Reset

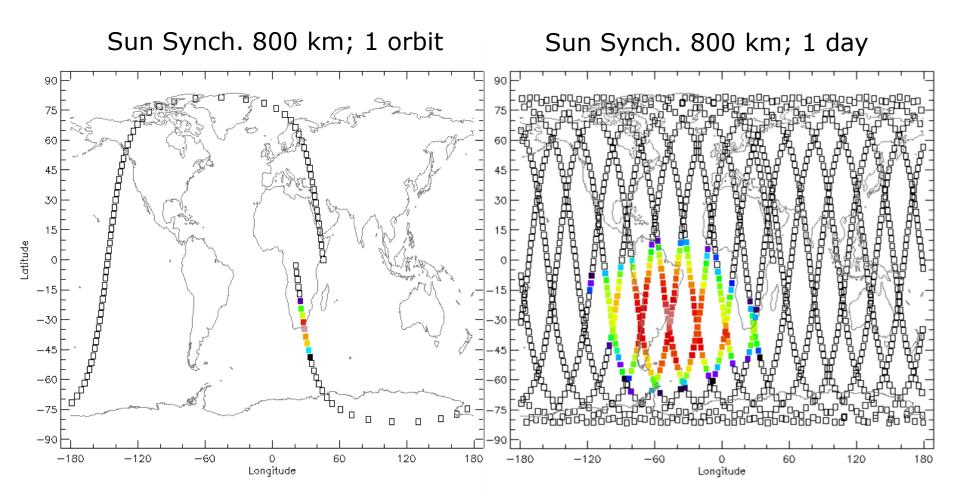
Run

Plotting of fluxes around orbit as world map, 3D, or time series possible.

USE THIS TO CHECK YOU HAVE ADEQUATELY COVERED THE MISSION.

Number of representative orbits





Also run for Solar particles & GCR



Once the trapped proton spectra model is run, the option to run the anisotropy model is available (relevant for low Earth orbits).

Also run the short and long term solar particle flux models* and GCR model.

Then move on to the effects tools

Coordinate generators Radiation sources and effects Radiation sources Trapped proton and electron fluxes Trapped proton flux anisotropy Short-term solar particle fluxes (only for SEU) Long-term solar particle fluences Galactic cosmic ray fluxes Shielded flux Solar cell radiation damage Damage equivalent fluences for solar cells (EQFLUX) NIEL based damage equivalent fluences for solar cells (MC-SCREAM) Long-term radiation doses Ionizing dose for simple geometries Non-ionizing energy loss for simple geometries Effective dose and ambient dose equivalent

^{*}For the Solar particle models, select a confidence level reasonable for the mission.

Radiation Effects Tools



1. SHIELDOSE-2 Dose as function of shielding thickness (p+, e-)

2. Non-Ionising dose NID as function of shielding thickness (p+, e-)

(Opto-electronic degradation)

3. EQFLUX/MC-SCREAM Solar cell degradation models (p+, e-)

4. CREME models SEU rate predictions (GCR, p+)

5. Geant4

a. Mulassis Simple geometries (slab, sphere)

b. GRAS Complex 3D geometries (GDML)

c. SSAT Ray tracing/Sector Shielding (GDML)

d. GEMAT SEU effects in components

Generating GDML files

Dose/Non-Ionising Dose Calculation



- Components are rated to a dose limit, beyond which they may fail or fade.
 This is typically in the range of <100 krad(Si). COTS components are closer to 1-15 krad(Si).
- The ionising dose limit is commonly established by testing using a Cobalt-60 source Gamma ray dose (very penetrating). The non-ionising dose limit is determined with proton beam tests.
- The radiation dose from the space environment is mixed (protons, electrons, cosmic rays), each with varying levels of shielding effectiveness.
 This rich environment is simplified into a single metric, e.g. TID, TNID, etc.
- Non-Ionising dose mostly affects Opto-Electronics and Bipolar devices.
- It is often necessary to establish how much dose will be received by a component in the environment given the shielding available:
 - Simple shielding geometries (solid sphere, slab, spherical shell, etc).
 - Realistic shielding geometry:
 - Sector shielding analysis
 - Full physics simulations (Geant4, Fluka, etc.)

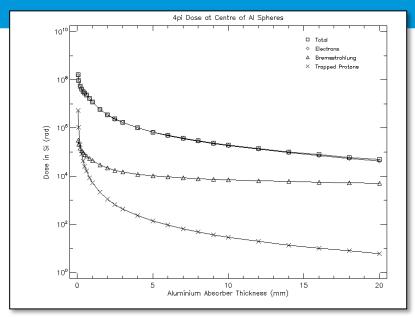
Simple Dose Effects Tools

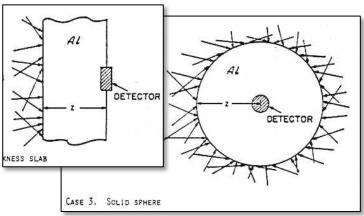


SHIELDOSE(2,2-Q) provides dosedepth curves for simple geometries. Similarly, the NIEL model provides non-ionising doses.

This is the simplest, and most conservative approach to RHA of a component.

Generally, the **solid sphere geometry** is used and can serve as an input to the sector shielding approach (SSAT, FASTRAD, DOSRAD, etc.)





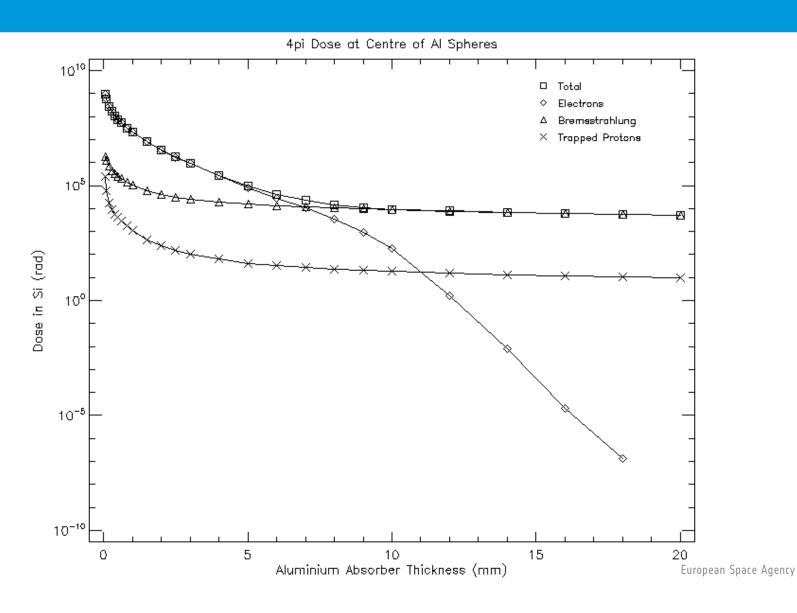
Simple Effects tools – SHIELDOSE-2



Coordinate generators Radiation sources and effects Radiation sources Trapped proton and electron fluxes Trapped proton flux anisotropy Short-term solar particle fluxes (only for SEU) Ionizing dose models: Parameters Long-term solar particle fluences Galactic cosmic ray fluxes Shielding depths: default values ▼ Shielded flux Dose model: SHIELDOSE-2 ▼ Solar cell radiation damage Damage equivalent fluences for solar cells (EQFLUX) Shielding configuration: centre of Al spheres NIEL based damage equivalent fluences for solar cells (MC Target material: Silicon Long-term radiation doses Ionizing dose for simple geometries Non-ionizing energy loss for simple geometries Non-ionizing energy loss: Parameters Effective dose and ambient dose equivalent Single event effects Shielding depths: default values ▼ Short-term SEU rates and LET spectra Damage factor [g(Si) MeV⁻¹]: 1.0E-11 Long-term SEUs and LET spectra Spacecraft charging

Dose-Depth Curve





Solar Cell Degradation



Two Methods:

Older JPL "EQFLUX" method (MC) SCREAM method

Older method relies on extensive test data related to equivalent 1 MeV electron fluxes and conversion of proton and electron spectra to an equivalent 1 MeV electron fluence

MC-SCREAM method converts the environmental spectra to Non-Ionising Dose and combines with solar cell test data based on NID to determine degradation.

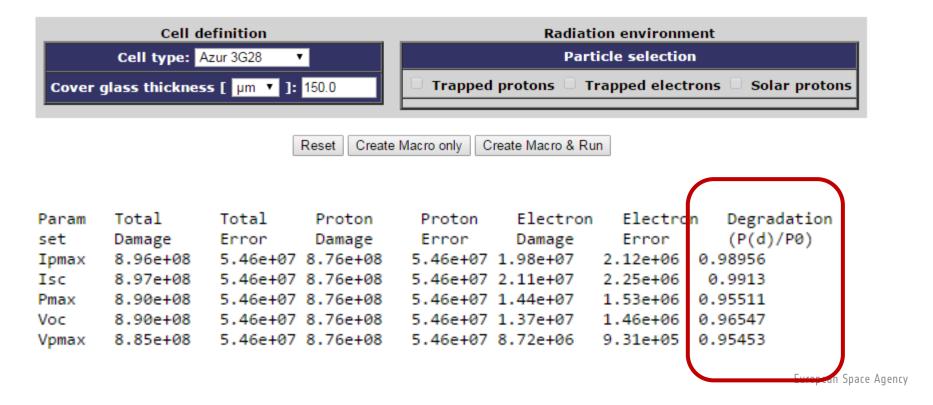
The MC-SCREAM method is preferred.

Solar Cell Degradation



In the lab, assume the use of Azur 3G28 solar cells.

In the report file, the damage for the cells will be provided, as will the relative degradation of the cells during the mission:



Upset Calculation - Theory



SEE are caused by **GCRs** and **protons**SEE can be:

destructive, e.g. Latch-up, or temporary, e.g. Single event upset/bit flip

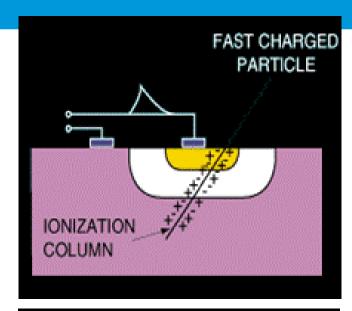
Mechanism is species dependent:

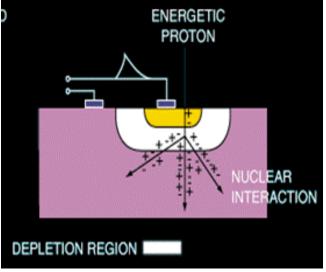
- **Ions**: cause upsets via ionization; this depends on the length of the ionization column in the sensitive volume of the component.
- Protons: cause upsets via a nuclear interaction leading to an ionization column (LET_{th} < 15 MeV cm²/mg).

Evaluating SEE requires knowledge of component

→ Test data

(some component data included in SPENVIS)



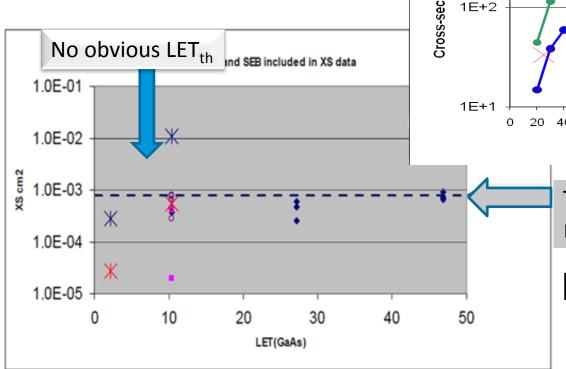


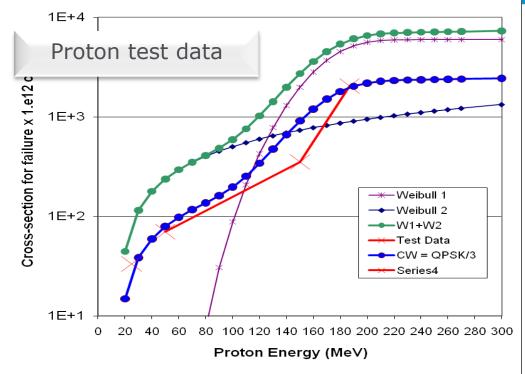
Device Test Data



Aim is to have a cross section curve as a function of incident particle LET or proton energy.

The data is typically fit to a Weibull or Bendel function





Test saturation cross section matches the visual inspection

Heavy Ion test data

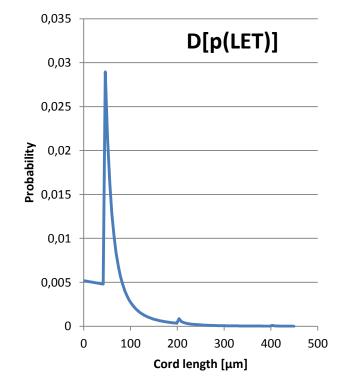
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Upset Calculation - Ions



CREME Rectangular parallelepiped (RPP):

- Device Dimensions (I×w×h) → RPP path length distribution. These dimensions are derived from actual device dimension measurements OR guessed from the cross section test data and device thickness.
- **D[p(LET)]** is the diff. path length distribution with $p(L)=(X/e)Q_c/L$ the length over which a ion of LET L will produce a charge Q_c .
- Critical Charge (Q_c) proportional to LET_{th}.
- Cross section (σ): is from the device test data.
- F(LET) is the integral LET spectrum



$$SEUrate(\#/bit-s) = 22.5\pi\sigma Q_{crit} \int_{22.5Q_{cri}/p_{max}}^{LET_{max}} \frac{D[p(LET)]F(LET)}{LET^2} dLE$$

European Space Agency

Upset Calculation - Protons



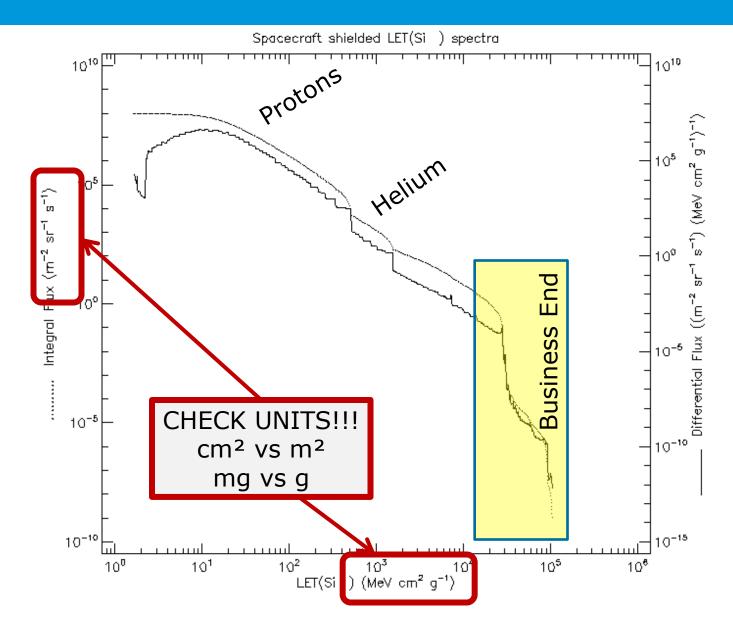
Protons: CREME 86/96 method:

- Cross-section data (Bendel, Weibull, Profit)
 - Profit is a tool for estimating the cross section from heavy ion test data.
- In principle, there are no angular effects to consider.
- Components with an LET $_{\rm th}$ < 15 MeV cm 2 /mg are considered susceptible. (Look up Si in Si Stopping power maximum value).

$$SEErate = \int f(E)\sigma(E)dE$$

LET Spectrum





SEE in SPENVIS



Shielding thickne	ss (Al equivalent):	0.2 cm		
	Device material:	Si (SRIM2008)	▼	
Device source:		user defined ▼		
Device name:		DEFAULT		
Shape Sensitive Volume: rectangular parallelepiped ▼				
Dimens	sions: • 38.7 x	38.7 × 2.0 × 2.0	[µm]	
Direct ionisat	ion upset rates	Proton ind	uced upset rates	
Cross-section method: S: L ₀ [MeV·cm ² /mg]:	Weibull function ▼ 0.66 0.55	Cross- section method: A [MeV]: B [MeV]:	Bendel function ▼ 4.88 7.09	
W [MeV·cm²/mg]: σ _{lim} [cm²/bit]: Algorithm: consta	5.49 1.5E-5 Int LET (CREME)	also input	test data and sibuli and meters	
Algorithm: constant LET (CREME) and of Weibull as instead of Weibull as instead of Parameters Bendel Parameters				

	Device source:	library ▼		
0	93L422 (BIPOLAR)(51x51x2)		
0	93L422AM (BIPOLAR)(38.7298x38.7298x2)			
0	2164 (MOS)(13x13x2)			
0	D424100V (4M DRAM)(5.96x5.96x1)			
0	HYB51410 (4M DRAM)(7.07x7.07x1)			
0	MB814100 (4M DRAM)(8.73x8.73x1)			
0	SMJ44100 (4M DRAM)(6.9x6	5.9x1)		
0	TC514100 (4M DRAM)(7.08x	(7.08x1)		
0	MT4C1004 (4M DRAM)(5.57x5.57x1)			
0	KM41C4000 (4M DRAM)(5.57x5.57x1)			
0	SAMSUNG 16M (3.3 V DRAM)(3.14x3.14x0.1)			
0	HITACHI 16M (3.3 V DRAM)	(1.5x1.5x0.64)		
0	MICRON 16M (3.3 V DRAM)	(1.38×1.38×0.81)		
0	IBM E 16M (3.3 V DRAM)(0.	51x0.51x0.22)		
0	LUNA-C (IBM 16M DRAM)(0	.94x0.94x1)		
0	01G9274 (IBM 4M DRAM)(1	.52×1.52×1)		
0	IBM 16M (4M DRAM)(0.88x0).88×1)		

Geant4 Models



Geant4 tools have similar inputs

- Source particle definitions
- Physics lists
- Material lists
- Geometry (GRAS, SSAT)
- Mulassis & GEMAT have their own geometry definitions.

Geant4 input files (macros & GDML) available for download to permit local runs.

Coordinate generators Radiation sources and effects Spacecraft charging Atmosphere and ionosphere **Magnetic field Meteoroids and debris** Miscellaneous **Geant4 Tools** General models Multi-Layered Shielding Simulation (MULASSIS) Geant4 Radiation Analysis for Space (GRAS) Geant4-based Microdosimetry Analysis Tool (GEMAT) Sector Shielding Analysis Tool (SSAT) Planet specific models Magnetocosmics **Planetocosmics** Common settings **Definition of source particles** User defined materials Geometry definition tool

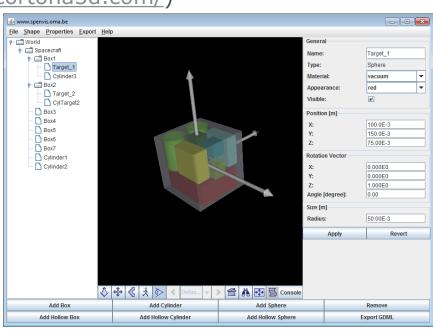
ECSS Space Environment Standard

Geometry Definition (GDML)



Two tools available to generate simple GDML geometries:

- HTML based Geometry Definition tool
 - Series of HTML pages to specify a geometry with up to 10 elements using CSG (sphere, box, cylinder)
 - Visualisation available at each step using VRML (need plug in, such as Cortona (http://www.cortona3d.com/)
- Java Geometry Generation Tool
 - Downloaded Java application
 - Interactive visualisation
- Upload GDML file from CAD tool, e.g. FASTRAD.



Sector Shielding Doses (SSAT)

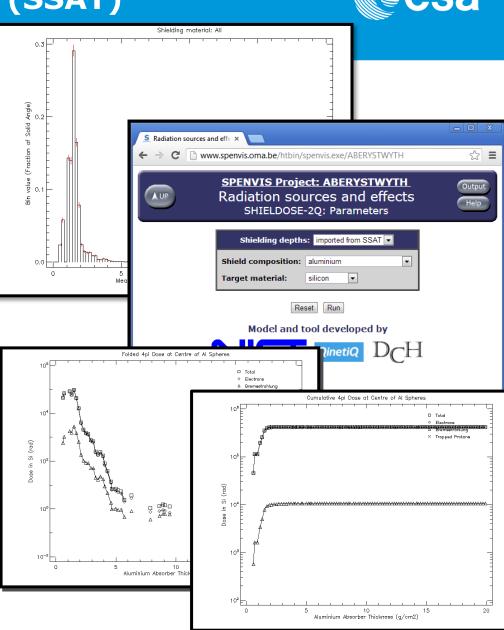
esa

Run SSAT to derive shielding distribution curve

Use SHIELDOSE-2 or SHIELDOSE-2Q and import shielding depths from SSAT.

Running SD2(Q) will fold Shielding distribution curve with the Dose-depth curve to provide Dose contribution for each shielding thickness for the geometry. The cumulative curve gives the dose in the target.

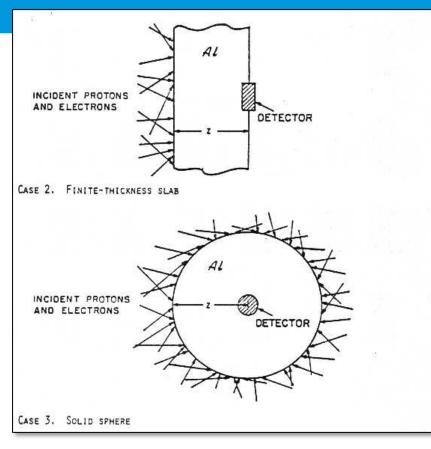
Look in SSAT GDML file analysis to find location of target (not obvious)



Mulassis



- 1. Simple geometries, like Shieldose:
 - a. Slab
 - b. Spherical shells (solid sphere)
- 2. Can be used to investigate graded, or exotic shields and targets.
- 3. Outputs include:
 - a. Shielded flux spectra
 - b. Total Ionising dose
 - c. Non-Ionising dose
 - d. Pulse height spectrum
 - e. Dose Equivalent (Human effects)



Recommend using slab geometries, as statistics are better. Although for solid sphere equivalent, an good approximation ($\sim 10\%$) is to use a spherical shell with a vacuum "core" that's $1/10^{th}$ the thickness of shield.

GRAS

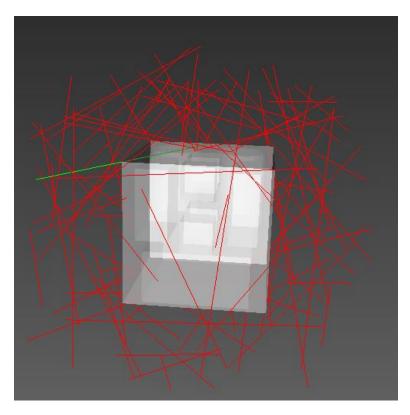


Complex 3D analysis module Geometry defined by GDML file Targets selected from GDML file

Can use the SPENVIS system to set up a **basic** run, download the input files and run more detailed analysis locally.

SPENVIS limits model runs to 600s,

Which can often be insufficient for a complex geometry to be analysed with adequate statistics.



GEMAT



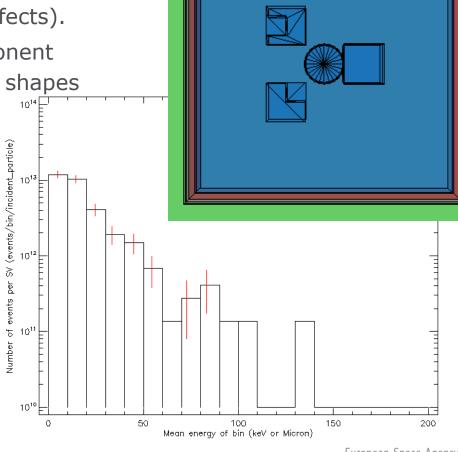
1. Used to study the effects of radiation on micro-electronics (Single Event Effects).

2. A geometry is defined for a component in terms of layers. Using common shapes

cylinder, box, "L" and "U" shapes

3. Analysis of

- a. incident flux
- b. Pulse height
- 4. Allows analysis of more complex geometries than provided by CREME.



Other Useful(?) Information



 The SPENVIS system, being an on-line system, limits model runs to only 600 CPU seconds. Some models can take a significant time to run – sample an orbit of interest or use a single relevant orbit.

2. Resources:

- a. SPENVIS BACKGROUND & HELP pages are extensive!
- b. Normally only 2 projects are provided to users, this can be increased by request to the SPENVIS team
- c. Similarly, CPU limits and disk usage can be extended beyond the default on request.
- d. Forums are available for assistance.
- e. It is possible to ZIP and download the entire project

3. ECSS Standards:

- a. ECSS-E-ST-10-04C: Environment specification
- b. ECSS-E-ST-10-12C: for determining radiation effects
- c. ECSS-Q-ST-60-15C: Radiation Hardness Assurance standard
- 4. For RHA a margin of a factor of 2 should suffice in most cases pace Agency

Determining Margins



- The trapped radiation belt models are stated to be accurate to within a factor of 2-3, but this will vary considerably over the magnetosphere.
 - In Geostationary orbit, AE-8 is known to be overestimating the fluxes.
 - At GNSS/Galileo orbits, AE-8 is underestimating the fluxes...usually.
 - The trapped proton model appears to be underestimating above, say 1000 km altitude.
 - The dynamic range of the environment can be several orders of magnitude→ regression to the mean is important, long missions → lower margins (maybe).
- The solar proton models, while they have a statistical confidence level, suffer due to underlying data calibration uncertainties.
- It is necessary to balance the margin policy with the risk that can be assumed for the mission – over engineering is expensive, but getting it wrong is even more expensive.

CREME Stopping Powers



CREME Stopping Powers in Silicon

